Fundam ental L im its of E lectronic N on linear-O ptical P henom ena

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U sing sum rules and a new dipole-free sum-over-states expression, we introduce a method for calculating the fundam ental lim its of the dispersion of the real and im aginary parts of all electronic nonlinear-optical susceptibilities. As such, these general results can be used to study any nonlinear optical phenom ena at any wavelength, making it possible to push both applications and our understanding of such processes to the lim its. These results reveal the ultimate constraints im posed by nature on our ability to control and use light.

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I. IN TRODUCTION

The interaction of light with matter is of fundamental importance in studying materials; [1] and, lies at the heart of many critical technologies that span telecommunications, [2] optical data storage, [3] threedim ensional nano-photolithography, [4, 5] and making new materials[6] for novel cancer therapies.[7] Because the strength of interaction, as quanti ed by the nonlinear-optical susceptibility, governs the e ciency of an application – and indeed whether or not a particular application is practical, making materials with ever larger nonlinear susceptibility has been the central focus of research in organic nonlinear optics. Is there a fundamental lim it to the susceptibility? Our work shows that nature in poses such an upper bound on all optical phenom ena. Prior work determ ined the fundam ental lim it of only the o -resonant susceptibility.[8, 9, 10, 11, 12, 13] In the present studies, we calculate the most general case: the fundam ental lim its of the dispersion of the real and im aginary parts of all electron ic nonlinear-optical susceptibilities, which can be used to study or apply any nonlinear optical phenom ena at any wavelength. Our work provides an understanding of the constraints in posed by nature on our ability to control and use light, and lays the foundation for developing better m aterials and novel applications.

W e focus on the second-order nonlinear-optical susceptibility of a molecule, often called the hyperpolarizability , as an example of the process we use for nding the fundam ental limit of any nonlinear susceptibility. Furtherm ore, since our goal is to set an upper bound, we will only consider the largest tensor component, $_{xxx}$. The electronic nonlinear-optical susceptibilities are calculated using perturbation theory in the dipole approximation, which yields an expression that incudes the excited state properties of all the quantum states of the system. This theoretical result is called a sum-over-states (SOS) expression, and for is given by:[14]

$$\max(!_{1};!_{2}) = \frac{e^{3}}{2}P_{!} ;! \qquad \sum_{n}^{\lambda^{2}} \frac{\dot{\mathbf{x}}_{0n}}{D_{nn}^{2}} \frac{\mathbf{x}_{n0}}{\mathbf{x}_{n0}} \qquad (1)$$

$$+ \frac{X^{1} {}^{0} X^{1} {}^{0} \frac{X_{0n} X_{nm} X_{m0}}{D_{nm}^{1} (! ; !)} 5;$$

where e is the electron charge, x_{nm} the n;m matrix element of the position operator, $x_{n0} = x_{nn} \quad x_{00}$ is the di erence in the expectation value of the electron position between state n and the ground state, D_{nm}^{-1} (!; !) gives the dispersion of (de ned later) and h! are the photon frequencies. The primes indicate that the ground state is excluded from the sum and the permutation operator P₁; directs us to sum over all six frequency permutations. Since the dipole moment of the molecule is proportional to the position ($p_x = ex$), we loosely call x_{nm} the transition moment and x_{nn} the excited state dipole moment. The rst and second terms in Equation 1 are called the dipole and the octupolar term s.

Equation 1 is a function of an in nite number of material parameters, x_{nm} and E_{n0} , so the maximum value of for each possible pair of photon energies requires an optim alset of transition m om ents and energies. The sum rules, which are directly derivable from the Schrödinger Equation, are relationships between the transition m om ents and energies. In the present work, we apply the sum rules to put the SOS expression of the nonlinear optical susceptibilities into a form that can be maximized to calculate the ultim ate nonlinear-optical susceptibility.

II. THEORY

The generalized Thom as Kuhn sum rules, derived directly from the Schrödinger Equation without any approximations, relate the matrix elements and energies to each other according to:[9]

$$\begin{array}{ccc} X^{a} & & \\ & E_{n} & \frac{1}{2} (E_{m} + E_{p}) & x_{m n} x_{n p} = \frac{h^{2} N}{2m} & _{m p}; \end{array}$$
(2)

where m is the mass of the electron, and N the number of electrons. The sum, indexed by n, is over all states of the system. Equation 2 represents an in nite number of equations, one for each value of m and p. As such, we refer to a particular equation using the notation (m; p).

Dening $E_{ij} = E_i$ E_j , we eliminate the dipole term using Equation (m;p) with m ϵ p:

$$\dot{X}^{k}$$

(E_{nm} + E_{np}) x_{m n} x_{np} = 0: (3)

Equation 3 can be rewritten by explicitly expressing the n = m and n = p terms, setting p = 0, and multiplying both sides by x_{0m} :[15]

$$\mathbf{x}_{m 0} \mathbf{\dot{x}}_{0m} \mathbf{\dot{j}}^{2} = \sum_{n \in m}^{\mathbf{X}^{1} \ 0} \frac{\mathbf{E}_{nm} + \mathbf{E}_{n0}}{\mathbf{E}_{m 0}} \mathbf{x}_{0m} \mathbf{x}_{m n} \mathbf{x}_{n0} : \quad (4)$$

Substituting Equation 4 into Equation 1, we get,

$$x_{xxx} (!_{1};!_{2}) = \frac{e^{3}}{2} P_{!_{1};!_{2}}$$

$$x^{i_{0}} x^{i_{0}} x^{i_{0}} \frac{x_{0m} x_{mn} x_{n0}}{D_{nm}^{1} (!_{1};!_{2})}$$

$$1 \frac{D_{nm}^{1} (!_{1};!_{2})}{D_{nn}^{1} (!_{1};!_{2})} 2\frac{E_{m0}}{E_{n0}} 1 ;$$
(5)

where,

$$P_{!_{1};!_{2}}D_{nm} (!_{1};!_{2}) = \frac{1}{2h^{2}} \frac{1}{(!_{ng} !_{1} !_{2})(!_{mg} !}$$

$$+ \frac{1}{!_{ng} + !_{2} (!_{mg} !_{1})}$$

$$+ \frac{1}{!_{ng} + !_{2} !_{mg} + !_{1} + !_{2}}$$

$$+ !_{1} \$!_{2} \text{ for the three previous term s];}$$

and where $!_{mg} = !_{mg}^{0}$ i $_{mg} = 2.h!_{mg}^{0}$ is the energy difference between states E_{m} and the ground state and $_{m}$ is the dam ping width. Equation 5 is called the dipole-free expression or the reduced hyperpolarizability, [15] where the second term in brackets in plicitly accounts for the dispersion of all dipolar term s.

W e use the ansatz that at m ost two states contribute to a m olecule's nonlinear susceptibility near its fundam ental lim it.[16, 17] (W e stress that a three-level SOS m odel does not dem and that the sum nules are truncated if the energies of the higher-lying state are high enough, so no truncation pathologies result. D etails will be described in a future publication.) U sing Equation 5,

$$\begin{array}{rcl} & & (!\,_{1};\,!_{2}) &=& \displaystyle \Pr_{2^{!}\,_{1};\,!_{2}} & 01 & 12 & 20 & (7) \\ & & & \displaystyle 4 \frac{1}{D_{12}^{1} & (!\,_{1};\,!_{2})} & \frac{2\frac{E_{20}}{E_{10}} & 1}{D_{11}^{1} & (!\,_{1};\,!_{2})} \\ & & + & \displaystyle \frac{1}{D_{21}^{1} & (!\,_{1};\,!_{2})} & \frac{2\frac{E_{10}}{E_{20}} & 1}{D_{22}^{1} & (!\,_{1};\,!_{2})} \\ & & & \quad 01 & 12 & 20D^{3L} & (!\,_{1};\,!_{2}); \end{array}$$

where $D^{3L}(!_1;!_2)$ is the term in brackets.

To further simplify Equation 7 so that we can calculate the extrem a, we again use the sum rules to express the matrix element product $_{01}$ $_{12}$ $_{20}$ in terms of $_{01}$. This leads to the exact result (without truncating the sum rules) is given by

$$j_{01} 12 20 j \frac{E}{P 1 E} 10 \frac{4}{M AX} \frac{4}{10};$$
 (8)

where $E = E_{10} = E_{20}$ and M_{AX} is the maximum allowed transition dipole moment to the rst excited state, which is related to the number of electrons, N, and the energy to the rst excited state, E_{10} , according to

$${}^{2}_{M AX} = \frac{e^{2}h^{2}}{2m E_{10}}N :$$
 (9)

Having exhausted all the sum rules that meet the three criteria for physical soundness, [16, 17] we assume that the remaining energies and transition moments are independent, so (via Equation 8) is maximal when $10 = \frac{10}{3} \frac{1}{10} \frac{A \times 1}{3}$. Combining Equations 7, 8 and 9, with $10 = \frac{10}{3} \frac{1}{10} \frac{A \times 1}{3}$, we get

$$_{\text{XXX}}(!_{1};!_{2}) \qquad {}_{0}^{\text{MAX}} \qquad \frac{1}{6} \frac{\text{E} \text{E} \frac{2}{10}}{1 \text{ E}} \qquad \text{D}^{\text{3L}}(!_{1};!_{2}) \qquad (10)$$

where \int_{0}^{MAX} is the fundam ental lim it of the o -resonant -(6) hyperpolarizability:[10]

$$\int_{0}^{MAX} = \frac{P_{4}}{3} \frac{2}{pm} \frac{eh}{m} \frac{3}{2} \frac{N^{3=2}}{E_{10}^{7=2}}$$
(11)

The maximum value of $_{xxx}$ for any second-order process at any wavelengths $!_1$ and $!_2$ is given by Equation 10 – a function of E, E_{10} , $_{n0}$, and N.

III. D ISCUSSION

All second-order nonlinear optical processes are bounded by Equation 10 if the three-level ansatz is obeyed. Figure 1 shows the real and in aginary parts of the maximum allowed hyperpolarizability as a function of the energy of the two incident photons, normalized to the maximum o -resonant value $_{0}^{MAX}$. Energies of the two dom inant states used in these plots are E₁₀ = 1eV, E₂₀ = 2eV and $_{10}^{FWHM} = _{20}^{FWHM} = 100 \text{ meV}$ (a 100 m eV width is a common approximation for organic molecules).

There are two dom inant peaks in the fundam entallim it of the real part of $_{xxx}$. The electrooptic hyperpolarizability, $_{xxx}$ (0;!), peaks at just under 80 times the o – resonant fundam ental lim it while the second harm onic generation hyperpolarizability, $_{xxx}$ (!;!), peaks at just under 50 times the o -resonant lim it. U sing these excited state energies and damping factors, the ultimate hyperpolarizabilities for an N -electron system is

$$ULTAMATE = 91;000 \quad 10^{30} \frac{\text{cm}^5}{\text{statcoul}} N^{3=2}:$$
 (12)



FIG.1: The dispersion of (a) the realpart and (b) the im aginary part of fundamental limit of normalized to the orresonant limit with E₁₀ = 1eV, E₂₀ = 2eV and $\frac{FWHM}{10} = \frac{FWHM}{20} = 100$ meV for a one-electron system.

For the o -resonant fundam ental lim it of (0;0), the second dom inant excited state energy is required to be in nite. Since the energy level spacing typically gets smaller for higher energy states, most molecules should fall far short of the lim it. Indeed, this could explain the factor of 30 gap between the best molecules and the o resonant lim it.[18, 19]

Figure 2a show saplet of the realpart of the fundam ental lim it of the resonant electrooptic hyperpolarizability $(0;h! = E_{10})$ norm alized to the o -resonant lim it (with $E_{10} = 1eV$) as a function of E_{20} , for various values of $\frac{FW}{10} = \frac{FW}{20} = \frac{FW}{20} = \frac{FW}{20}$. As expected, the maximum resonant value increases as the width decreases. However, the hyperpolarizability peaks when the second dom inant excited state is close in energy to the rst dom inant excited state. In the lim it of zero width, peaks when the two dom inant states are degenerate. Such excited state energy spacing is common in organicm olecules, so it may be possible to identify m olecules with an ultra-large resonant response using this strategy.



FIG.2: (a) The realpart of fundam entallim it of norm alized to the o -resonant lim it with $E_{10} = 1eV$ as a function of E_{20} , for various values of $\frac{FW}{10} + \frac{FW}{20} + \frac{FW}{20} + \frac{FW}{20}$; and (b) The real part of the fundam ental lim it of the second harm onic norm alized to the o -resonant lim it with $E_{10} = 1eV$ as a function of E_{20} , for various o -resonant pump wavelengths.

The structure required of a molecule to be at the fundam ental limit is thus dierent on and o resonance. Our present calculations, in the zero-frequency limit of

(!;!), are sum m arized by the series of plots in F igure 2b, which show the fundam ental lim its for several photon energies between 0 and 0:4 eV with a damping factor of $_{n0} = 100m \text{ eV}$. For h! = 0, the fundam ental lim it clearly approaches the norm alized value of unity, as previously calculated. For each o -resonant photon energy, the fundam ental lim it increases as h! ! E $_{10}$ =2 and the second excited state energy approaches in nity.

The lim its in the dispersion of the real and imaginary parts of the third-order susceptibility, $(!_1;!_2;!_2)$, can be calculated in a sim ilarway using the three-levelansatz in dipole-free form .[15] The sum rules can then be used to re-express the results in a form analogous to E quations 10. A full discussion of third-order susceptibilities will be presented in a future paper.

It is interesting to apply our results to typical molecules. For example, consider a molecule with 50 conjugated electrons whose rst excited state energy is $E_{10} = 1.55 \, \text{eV}$ (800 nm) and $= 100 \, \text{meV}$. A coording to Equation 11,[10] the o -resonant value of the hyperpolarizability yields $_0^{\text{M-AX}} = 90;500 \quad 10^{-30}$ esu. U sing our new theoretical results, the resonant electrooptic hyperpolarizability is $_{\text{M-AX}}$ (0;h! = E_{10}) = 7;240;000 10^{-30} esu. For a polar-aligned bulk materialm ade of such molecules, at a concentration of 10^{21} cm 3 , the fundamental limit of the o-resonant electrooptic coe cient is $r_{\text{M-AX}}$ (0;0) = 3;000 pm =V and the resonant case yields $r_{\text{M-AX}}$ (0;h! = E_{10}) = 240;000 pm =V . Higher concentration system s, or ones with narrower widths, would have even higher values. As such, our calculations show that there is room for considerable in provem ent over today's best materials.

Our theory is general and few approximations have been used in calculating the dispersion of the limits. We start with a dipole-free form of the SOS expression for

and apply the ansatz that the oscillator strength is dom inated by two excited states when the susceptibility approaches the fundam ental lim it. So in our calculation, the three-levelm odel is not an approxim ation, but an exact model for a system at the lim it.[16, 17] Furtherm ore, since this does not dem and the sum rules to be truncated to three levels, no truncation pathologies result. The fact that most real molecules are not well approxim ated by a three-levelm odelm ay explain the factor-of-thirty gap between the fundam ental lim it and the best molecules. The fact that a clipped harm onic oscillator yields a value of that is near the fundam ental lim it [19] shows that the calculated lim its are not large overestim ates. The set of all theoretical calculations and m easurem ents are consistently below the fundam ental lim it, leading credence to the theory.

We only consider processes that are described by a sum -over-states expression which inherently assumes the electric dipole approximation (i.e. the wavelength of light is sm all compared with the size of the quantum system under study). W hile it is often the case that higher-order terms or magnetic moments may be larger than low erorder terms, the fundamental lim its of the higher-order terms should not be larger than the fundamental lim its of low er-order terms. Secondly, we only consider the largest diagonal components of and . Short of unexpected new Physics, we would not expect that the maximum lim it of an o -diagonal component of a susceptibility to exceed a diagonal one. Note that our calculations include resonance, so K leinm an Symmetry is expected to be broken, leading to potentially large o -diagonal components of susceptibilities that are disallowed o resonance. To treat such cases, one would need to use o -diagonal sum rules.

In conclusion, we have applied the sum rules to determ ine the fundam ental lim its of the dispersion of any com plex susceptibility, thus being applicable to any electronic nonlinear-optical process. We nd that to attain the fundam ental lim it, o -resonant processes require a di erent molecular structure than on resonance, so one approach of molecular engineering does not suit all applications. Our work can be applied to calculating and optim izing the gure of merit of materials for specic applications; provides a method for comparing measured values of and without having to resort to determ ining $_0$ and $_0$, which requires the use of unreliable dispersion models; and gives guidance for designing new materials and how their dispersion can be tuned for for a desired response. C learly, there is still room for substantial in provem ents in all nonlinear molecular susceptibilities, especially on resonance in system s with closely-spaced excited states, such as provided by octupolar m olecules.[20]

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